

# 2N3704



# **NPN General Purpose Amplifier**

This device is designed for use as general purpose amplifiers and switches requiring collector currents to 300 mA. Sourced from Process 10. See PN100 for characteristics.

# **Absolute Maximum Ratings\***

TA = 25°C unless otherwise noted

Symbol	Parameter	Value	Units	
$V_{CEO}$	Collector-Emitter Voltage	30	V	
V <sub>CBO</sub>	Collector-Base Voltage	50	V	
V <sub>EBO</sub>	Emitter-Base Voltage	5.0	V	
I <sub>C</sub>	Collector Current - Continuous	500	mA	
T <sub>J</sub> , T <sub>stg</sub>	Operating and Storage Junction Temperature Range	-55 to +150	°C	

<sup>\*</sup>These ratings are limiting values above which the serviceability of any semiconductor device may be impaired.

# **Thermal Characteristics**

TA = 25°C unless otherwise noted

Characteristic	Max	Units
	2N3704	
Total Device Dissipation	625	mW
Derate above 25°C	5.0	mW/°C
Thermal Resistance, Junction to Case	83.3	°C/W
Thermal Resistance, Junction to Ambient	200	°C/W
	Total Device Dissipation Derate above 25°C Thermal Resistance, Junction to Case	ZN3704           Total Device Dissipation         625           Derate above 25°C         5.0           Thermal Resistance, Junction to Case         83.3

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<sup>1)</sup> These ratings are based on a maximum junction temperature of 150 degrees C.

2) These are steady state limits. The factory should be consulted on applications involving pulsed or low duty cycle operations.

# **NPN General Purpose Amplifier**

Max

Min

Units

Electrical Characteristics TA = 25°C unless otherw			
Symbol	Parameter		Test Conditi

OFF CH	ARACTERISTICS				
$V_{(BR)CEO}$	Collector-Emitter Breakdown Voltage*	$I_C = 10 \text{ mA}, I_B = 0$	30		V
V <sub>(BR)CBO</sub>	Collector-Base Breakdown Voltage	$I_C = 100  \mu A,  I_E = 0$	50		V
$V_{(BR)EBO}$	Emitter-Base Breakdown Voltage	$I_E = 100 \ \mu A, \ I_C = 0$	5.0		V
I <sub>CBO</sub>	Collector Cutoff Current	$V_{CB} = 20 \text{ V}, I_{E} = 0$		100	nA
I <sub>EBO</sub>	Emitter Cutoff Current	$V_{EB} = 3.0 \text{ V}, I_{C} = 0$		100	nA

**Test Conditions** 

## ON CHARACTERISTICS\*

h <sub>FE</sub>	DC Current Gain	$V_{CE} = 2.0 \text{ V}, I_{C} = 50 \text{ mA}$	100	300	
V <sub>BE(on)</sub>	Base-Emitter ON Voltage	$V_{CE} = 2.0 \text{ V}, I_{C} = 100 \text{ mA}$	0.5	1.0	V
V <sub>CE(sat)</sub>	Collector-Emitter Saturation Voltage	$I_C = 100 \text{ mA}, I_B = 5.0 \text{ mA}$		0.6	V

## SMALL SIGNAL CHARACTERISTICS

$C_ob$	Output Capacitance	V <sub>CB</sub> = 10 V, f = 1.0 MHz		12	pF
f <sub>T</sub>	Current Gain - Bandwidth Product	$I_C = 50 \text{ mA}, V_{CE} = 2.0 \text{ V},$	100		MHz

<sup>\*</sup>Pulse Test: Pulse Width  $\leq$  300  $\mu$ s, Duty Cycle  $\leq$  2.0%

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#### **Definition of Terms**

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